

<b>Notice of References Cited</b>	Application/Control No. 10/643,422	Applicant(s)/Patent Under Reexamination TANAKA ET AL.	
	Examiner Kim-Kwok CHU	Art Unit 2627	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,065,287	06-2006	Heredia et al.	386/52
*	B	US-6,879,843	04-2005	Kim, Dong-Woo	455/557
*	C	US-6,792,007	09-2004	Hamada et al.	725/134
*	D	US-5,880,386	03-1999	Wachi et al.	84/601
*	E	US-4,868,869	09-1989	Kramer, Gregory	84/622
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.